

# Reprints from Computing Reviews<sup>1</sup>

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GALIL, ZVI; ITALIANO, GIUSEPPE F.; AND SARNAK, NEIL  
**Fully dynamic planarity testing with applications.**  
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Since 1974, it has been known how to test graphs for planarity in linear time. This involves an  $O(n)$  algorithm to see if the abstract graph's structure with  $n$  vertices is embeddable in the plane and, if so, to construct such a mapping. The incremental planarity testing problem is to perform a sequence of new edge tests and inserts on a graph known to be planar; better results for this problem were shown only ten years ago:  $O(\log^2 n)$  amortized time per operation. By the fully dynamic planarity testing problem, in addition to tests and inserts, the authors allow  $\text{Delete}(x, y)$ , which removes edge  $(x, y)$  from the tested graph. Planarity testing has natural applications in many areas, including VLSI layout, graphics, and CAD. In all these, there is a need to deal with fully dynamic updates, which may change the planar embedding. In this 60-page paper, we see the previous bounds pressed to the present limits: dynamic tests and deletions  $O(n^{2/3})$  worst-case time per operation; and dynamic inserts  $O(n^{2/3})$  amortized time per operation. The key insight, which may only be appreciated by algorithmic graph theorists, is to exploit compressed certificates (edge clusters) that certify the planarity using a much smaller subset of edges and vertices of  $G$ . Incidentally, the same techniques can be applied to biconnected and triconnected graphs. This work has 59 references, 55 lemmas, and only four theorems (Theorem 1 appears on the 52nd page!); it is a prime case for the value of *Computing Reviews*, as otherwise it is a relatively inaccessible archival version of a fairly readable symposium paper [1]. This version was in the review process for exactly six years, which seems excessive.

—F. N. Springsteel, Columbia, MO

## REFERENCES

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- [1] GALIL, Z.; ITALIANO, G.; AND SARNAK, N. Fully dynamic planarity testing (extended abstract). In *Proceedings of the 24th Annual ACM Symposium on the Theory of Computing*. R. Kosaraju, Chr. (Victoria, B. C., Canada, May 4–6, 1992), ACM, New York, 1992, 495–506.

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